

FGPF30N45T 450V, 30A PDP Trench IGBT

Features

- High Current Capability
- Low saturation voltage: $V_{CE(sat)} = 1.55V @ I_C = 30A$
- High input impedance
- · Fast switching

April 2009



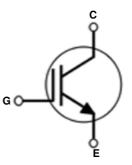
General Description

Using Novel Trench IGBT Technology, Fairchild's new sesries of trench IGBTs offer the optimum performance for PDP applications where low conduction and switching losses are essential.

Applications

PDP System





Absolute Maximum Ratings

Symbol	Description		Ratings	Units	
V _{CES}	Collector to Emitter Voltage		450	V	
V _{GES}	Gate to Emitter Voltage		±30	V	
I _{CM (1)}	Pulsed Collector Current	@ T _C = 25°C	120	А	
P _D	Maximum Power Dissipation	@ T _C = 25°C	50.4	W	
	Maximum Power Dissipation	@ T _C = 100 ^o C	20.1	W	
TJ	Operating Junction Temperature		-55 to +150	°C	
T _{stg}	Storage Temperature Range		-55 to +150	°C	
TL	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C	

Notes:

1: Repetitive test , Pulse width=100usec , Duty=0.1

* Ic_pluse limited by max Tj

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Units	
$R_{\thetaJC}(IGBT)$	Thermal Resistance, Junction to Case	-	2.48	°C/W	
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient	-	62.5	°C/W	

Device N	vice Marking Device Pa		Pack	kage			Packaging Type		Qty per Tube	
FGPF30N45T FGPF30N45TTU TC		TO-2	0-220F RoHS		Rail / Tube		50ea			
		-			http://www.fairchildse		<u>pany/greer</u>	n/rohs_gree	<u>en.html</u> .	
Symbol		Parameter		Test Conditions		Min.	Тур.	Max.	Units	
Off Charac	teristics									
BV _{CES}	Collector	to Emitter Breakdown	Voltage N	/ _{GE} = 0V,	I _C = 250μA	450	-	-	V	
ΔBV _{CES} ΔT _J	Temperature Coefficient of Breakdown Voltage		akdown N	$V_{GE} = 0V, I_{C} = 250 \mu A$		-	0.5	-	V/ºC	
I _{CES}	Collector	Cut-Off Current	١	V _{CE} = V _{CE}	_{ES} , V _{GE} = 0V	-	-	100	μA	
I _{GES}	G-E Leak	age Current			$V_{CE} = 0V$	-	-	±400	nA	
On Charac	teristics		H				ł	1	I	
V _{GE(th)}		shold Voltage	I	$I_{C} = 250 \mu A, V_{CE} = V_{GE}$		2.5	4.0	5.0	V	
	t) Collector to Emitter Saturation Voltage			I _C = 20A, V _{GE} = 15V		-	1.35	1.6		
			Voltage I	I _C = 30A, V _{GE} = 15V		-	1.55	-	V	
				$I_{C} = 30A, V_{GE} = 15V,$ $T_{C} = 125^{\circ}C$		-	1.53	-	V	
Dynamic C	haracteris	stics								
C _{ies}	Input Cap			$V_{CE} = 30V, V_{GE} = 0V,$		-	1610	-	pF	
C _{oes}	Output Ca	apacitance				-	88	-	pF	
C _{res}	Reverse	se Transfer Capacitance		f = 1MHz		-	68	-	pF	
Switching	Character	istics								
t _{d(on)}	1	Delay Time				-	19	-	ns	
t _r	Rise Time	9		$V_{CC} = 200V, I_C = 30A,$ $R_G = 15\Omega, V_{GE} = 15V,$ Resistive Load, $T_C = 25^{\circ}C$		-	57	-	ns	
t _{d(off)}	Turn-Off	Delay Time	\ F			-	119	-	ns	
t _f	Fall Time		F			-	220	330	ns	
t _{d(on)}	Turn-On I	Delay Time				-	20	-	ns	
t _r	Rise Time	Э	· · · ·	100 - 200	V Ia - 30 4	-	60	-	ns	
t _{d(off)}	Turn-Off I	Delay Time		$ \begin{array}{c} & V_{CC} = 200V, \ I_C = 30A, \\ & R_G = 15\Omega, \ V_{GE} = 15V, \\ & \text{Resistive Load}, \ T_C = 125^{\circ}\text{C} \end{array} $		-	122	-	ns	
t _f	Fall Time					-	265	-	ns	
Qg	Total Gate	e Charge				-	73	-	nC	
Q _{ge}	Gate to E	mitter Charge		$V_{CE} = 200V, I_C = 30A,$ $V_{GE} = 15V$		-	11	-	nC	
Q _{gc}	Gate to C	ollector Charge	`			-	33	-	nC	

Typical Performance Characteristics



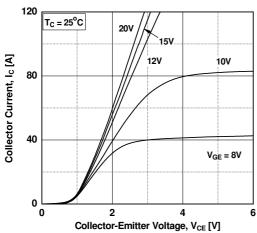


Figure 3. Typical Saturation Voltage Characteristics

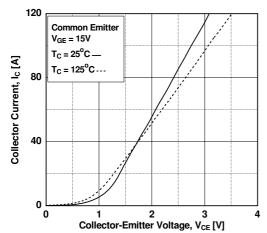


Figure 5. Saturation Voltage vs. Case Temperature at Variant Current Level

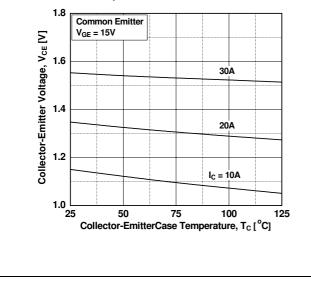


Figure 2. Typical Output Characteristics

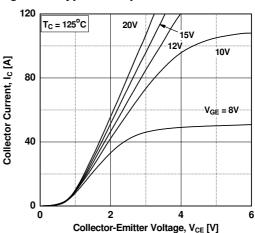


Figure 4. Transfer Characteristics

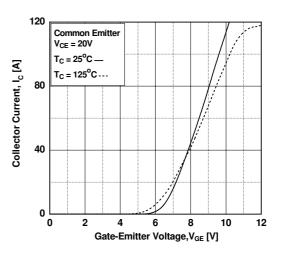
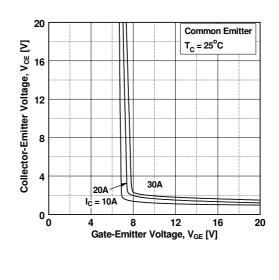


Figure 6. Saturation Voltage vs. V_{GE}



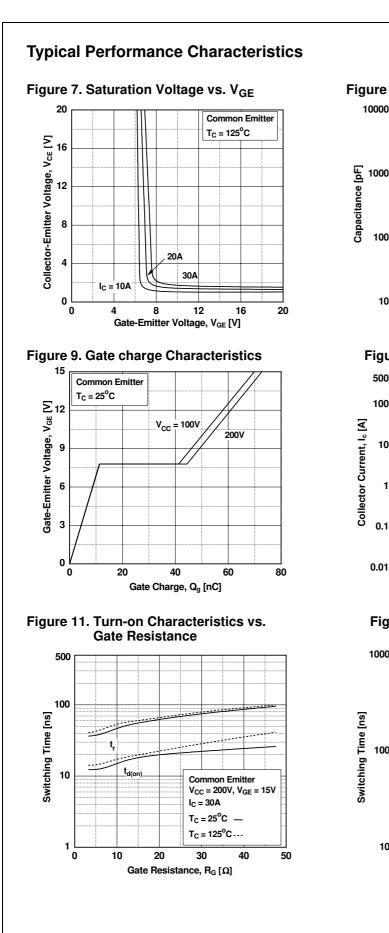
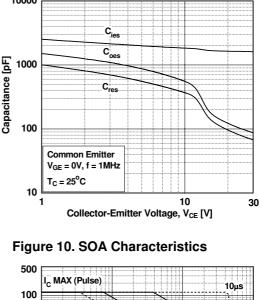


Figure 8. Capacitance Characteristics



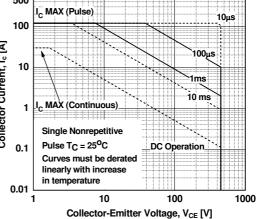
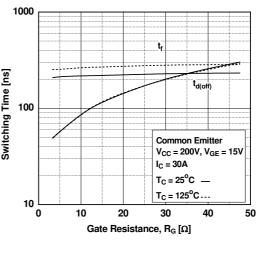
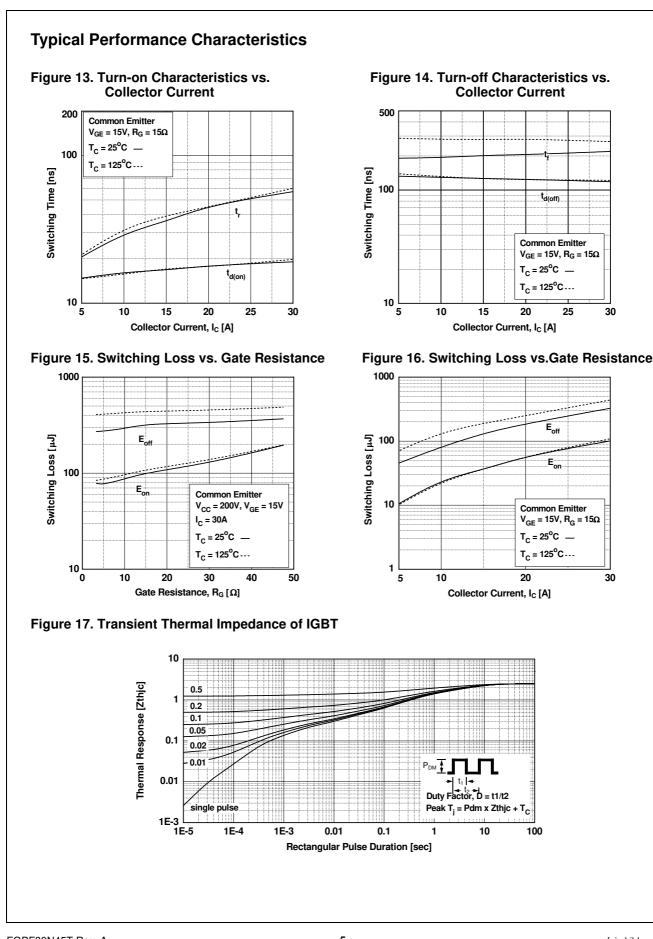


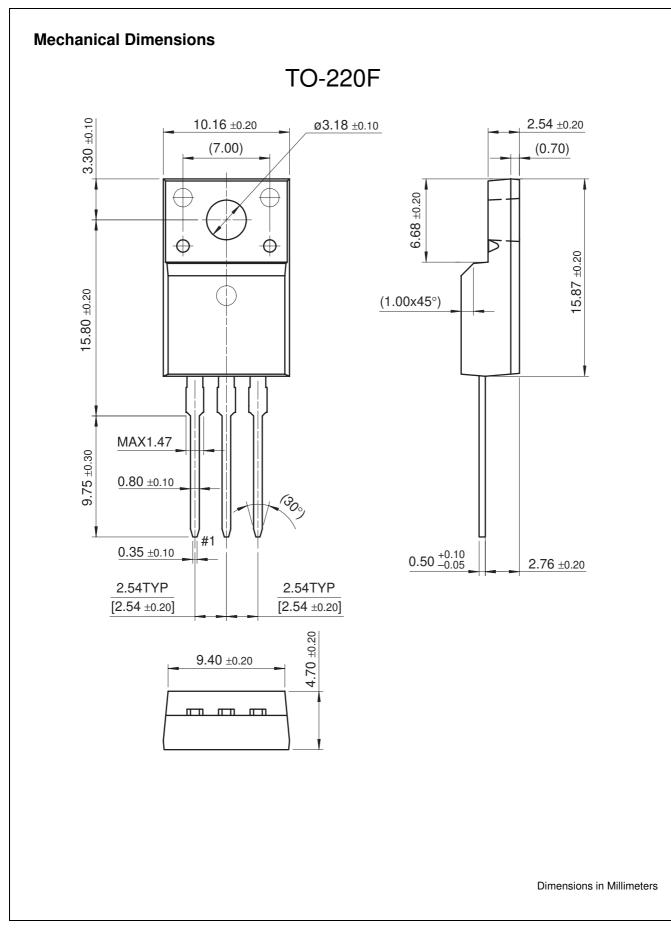
Figure 12. Turn-off Characteristics vs. Gate Resistance

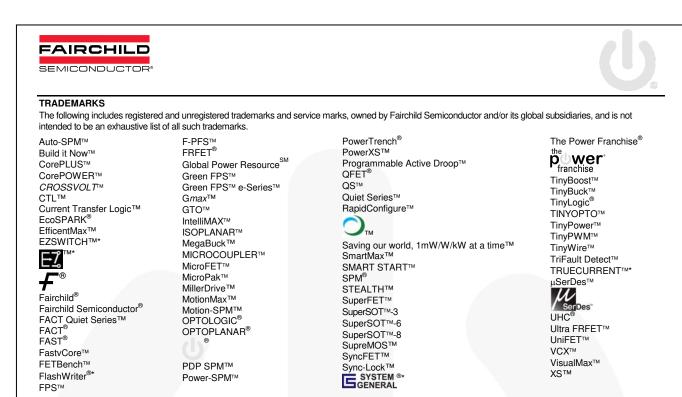


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